

3. **Sensitivity.** It is the scale factor of a sensor that is measured in terms of change in output signal for every change in the input measured. It is measured in mV/gm.

4. **Frequency response.** It measures the limit of the frequency for the sensor-detected motion and the reported output. It is measured in hertz (Hz).

5. **Sensitivity axis.** The inputs detected by the accelerometers are always in reference to an axis. Single-axis accelerometers can detect inputs only along one plane whereas tri-axis accelerometers can detect inputs from any direction. So the tri-axis accelerometers are used in most of the applications.

6. **Size and mass.** Both the size and the mass of an accelerometer should be small as compared to that of the system to be monitored, otherwise it can affect and also change the characteristics of the object that is being tested.

The micro-electro-mechanical sensor (MEMS) accelerometer is special as compared to other accelerometers owing to its capability and small size. "The parameters to select an MEMS accelerometer are power consumption, sensitivity to 'g' force, ADC bit size, device calibration, axis support and presence of internal FIFO data buffer. Newer accelerometers support additional features such as free-fall detection, motion detection, gesture control and orientation detection algorithms, so designers can exploit these features depending on the application requirements," says Avinash Babu, senior project manager, Embedded Systems, Mistral Solutions.

So some points on the basis of which a gyroscope can be selected are:

Measurement range. It specifies the maximum angular speed measured by the gyro sensor. It is measured in degrees per second ($^{\circ}/\text{sec}$).

Number of sensing axes. A gyroscope can measure angular rotation either in one, two or three axes; however, a multi-axis gyro has multiple single-axis gyros that are oriented orthogonally to one another.

Non-linearity. It specifies the closeness of the output voltage to linearity and is proportional to the actual

angular rate. It is measured either as an error in percentage or in parts per million (ppm).

Shock survivability. Since both the linear and angular rotations occur in a gyroscope, it is necessary to check the force it can withstand without falling. However, a gyroscope is expected to withstand very large shocks (measured in g's) without breaking.

Bandwidth. It is the number of measurements made in one second. It is quoted in hertz (Hz).

Angular random walk (ARW). It is the measurement of gyro noise in $\text{deg}/\text{hour}^{1/2}$ or $\text{deg}/\text{sec}^{1/2}$.

Bias instability. It measures the goodness of a gyro in degrees per hour ($^{\circ}/\text{hr}$).

Challenges faced by the design engineers

Technology brings challenges and the designers have to overcome all these in order to create something new. Babu says, "Placement of a sensor on the PCB is very crucial and is often overlooked. For optimal motion detection, a sensor needs to be placed away from the centre of the device, which helps to ensure better acceleration readings and makes them more significant in the detection of smaller motions from a higher moment of inertia than when they are placed right on the centre of the movement.

"Care must be taken to ensure that the package is not stressed by holes, or components on the PCB are not placed too close to the accelerometer. It is important to place the sensor where it is not vulnerable to be pushed or otherwise affected directly by the user's hands. It is good to avoid placing the sensor near components that may have large temperature variations, or that are constantly very hot, as this will affect the offset of the sensor."

"Footprint of the sensor, supply current and cost need to be minimal in all consumer applications. Functional safety and reliability of the sensor in vast operating conditions becomes a major challenge in automotive applications," explains Vikas Choudhary,

engineering manager, MEMS and Sensors at Analog Devices, Inc. The other challenges are power consumption, sensor integration and calibration.

"In battery-operated devices, the power consumed by the sensors should be minimised as much as possible and the sensors must support low-power mode in suspend, preferably with interrupt functions. This would help the host processor to get relieved from the continuously polling data. Even though enough care is taken during the layout phase, there are uninterrupted interferences to these sensors due to which they report inaccurate values. Thus there is a need for the calibration of these sensors and the use of a fine-tuned software for an optimum calibration," explains Babu.

This is not all. The other factor that can affect the working of these sensors to a larger extent is the electromagnetic interference, especially the very high frequency (VHF) EMF. T. Anand says, "Electromagnetic interference can produce false signal outputs. On the other hand, VHF-level electromagnetic interference can also cause intermodulation distortion and produce low-frequency measurement errors."

What is new in this segment?

Sony Ericsson's shake control and Samsung's motion play are examples of new technologies that make good use of an accelerometer. Microsoft uses accelerometer-based features in its Windows Embedded Compact for different touch-screen applications on Windows 8. Manufacturers also use them in devices to protect their hard drives from getting damaged in case of a free-fall.

Industries currently use MEMS-based accelerometers. They work on the principle of displacement of a small proof mass that is etched into the silicon surface of the IC and is suspended by small beams. As soon as the acceleration is applied to the device, a force is developed that displaces the mass. The support beams that act as a spring, and the fluid trapped in the IC that acts as a damper, result in the second-order lumped physical system which acts as

TABLE I
Accelerometer Products

Company	Part Number	Output	Dynamic Range	Sensitivity	Frequency Response	Sensitivity Axis	Weight	Size
Analog Devices	ADXL377	Analogue	±200 gm	6.5 mV/gm	1.6kHz	X, Y, Z		3×3×1.45mm
Analog Devices	ADXL375	Digital-SPI & I ² C	±200 gm	20.5 LSB/gm	1.6kHz	X, Y, Z	30 mg	3×5×1mm
STMicroelectronics	LIS332AX	Analogue	±2 gm	336 mV/gm	2.0kHz	X, Y, Z	30 mg	3×3×1.0mm
STMicroelectronics	ALS326DQ	Digital	±2 gm, ±6 gm	±2 g- 1024 LSB/gm ±6 g- 340 LSB/gm	640Hz	X, Y, Z	0.2 gm	7×7×1.8mm
Freescale Semiconductor	MMA1211D	Analogue	±169 gm	13.33 mV/gm	400Hz	Z		
Freescale Semiconductor	MMA16xxKW	Digital	±50 gm - ±312.5 gm	10.24 LSB/gm, 8.192 LSB/gm, 4.096 LSB/gm, 2.731 LSB/gm, 1.638 LSB/gm	400Hz	Z		
Bosch Sensortec	BMA222E	Digital	±2 gm, ±4 gm, ±8 gm, ±16 gm	±2gm-64 LSB/gm ±4gm-32 LSB/gm ±8gm-16 LSB/gm ±16gm-8 LSB/gm	8-1000Hz	X, Y, Z		2×2×0.95mm
Bosch Sensortec	BMA250	Digital	±2 gm, 4 gm, 8 gm, 16 gm	256LSB/gm, 128LSB/gm, 64LSB/gm, 32LSB/gm	8H-1kHz	X, Y, Z		2×2×0.95mm
Bosch Sensortec	BMI055	Digital	±2 gm, 4 gm, 8 gm, 16 gm	1024LSB/gm, 512LSB/gm, 256LSB/gm, 128LSB/gm	8Hz-1kHz	X, Y, Z		
Murata Electronics North America	SCA3060-D01-1	Digital	±2 gm	1000 counts/gm	9Hz	X, Y, Z		7.6×3.3×8.6mm
Murata Electronics North America	SCA1020-D02-1	Analogue, Digital	±1.7 gm	1.2V/gm	50±30Hz	Y, Z	<1.2 gm	9×5×16mm
Measurement Specialties Inc.	1-1001497-0	Analogue	±150 gm	10mV/gm	2Hz-20kHz	X or Y	8 gm (5 cables)	
Measurement Specialties Inc.	3038-0050	Ratiometric	±50 gm	1mV/gm	1kHz			
Kionix Inc.	KXTF9-2050	Digital	±2 gm, 4 gm, 8 gm	64count/gm, 32count/gm, 16count/gm (8bit), 1024count/gm, 512count/gm, 256count/gm (12bit)	25Hz	X, Y, Z		3×3×0.9mm
Kionix Inc.	KXCJ9-1008	Digital	±2 gm, 4 gm, 8 gm	1024 count/gm, 512 count/gm, 256 count/gm, 64 count/gm, 32 count/gm, 16 count/gm	800Hz	X, Y, Z		3×3×0.9mm
Kionix Inc.	KXR94-2050	Analogue	±2 gm	660mV/gm	800Hz	X, Y, Z		5×5×1.2mm
Memsic Inc.	MXR9500MZ	Analogue, Ratiometric	±1.5 gm	500mV/gm	17Hz	X, Y, Z		7×7×1.8mm
Parallax Inc.	28526	Digital - I ² C	±2 gm, 4 gm, 8 gm	64count/gm, 32count/gm, 16count/gm (8bit), 1024count/gm, 512count/gm, 256count/gm (12bit)	250Hz	X, Y, Z		12.7×15.2×11.7mm

the source of non-uniform frequency response and limited operation bandwidth of the accelerometer.

On the other hand, new gyroscopes have been launched by companies like Epson for car navigation applications. KMX61G is the world's first micro-smp magnetic gyro launched in 2013 by Kionix, with an integrated sensor fusion technology. This reduces the current drawn by up to 90 per cent as compared to the other traditional gyros. New components like these would allow product

designers to incorporate the gyro functionality in products that were restricted in the past from the inclusion of gyro due to their high-power consumption.

Enhancing flexibility

When swapping similar components, engineers always know that not all components are created equal and they will always be mismatched. However, mistakes will always happen and sometimes they tend to be the expensive ones.

Let us consider what happened to Apple's iPhone 5S—by switching the accelerometer from a STMicroelectronics LIS331DLH to a Bosch Sensortec BMA220, the phone literally lost its sense of balance. Now companies like Kionix are coming out with performance optimisation tools that allow a designer to manipulate power and noise levels through a downloadable GUI. This helps them tune the sensor to meet their system's potentially unique requirements through precise design parameter choices.

TABLE II
Gyroscope Products

Company	Product Number	Measurement Range (°/sec)	Number of sensing axes	Nonlinearity (% of Full Scale)	Shock Survivability	Bandwidth	Output Type
Analog Devices	ADXRS610	±300	Z	0.10%	2000 gm	0.01-2500Hz	Analogue
Analog Devices	ADXRS150	±150	Z	0.10%	2000 gm	14,000Hz	Analogue
Freescale Semiconductor	MMA7260Q	±1.5/2/4/6	X, Y, Z	1.00%		350/150Hz	Digital
Freescale Semiconductor	FXAS21000	±1600	X, Y, Z	1.00%		1.5625-200Hz	Digital
STMicroelectronics	A3G4250D	±245	X, Y, Z	5.00%		>140Hz	Digital
STMicroelectronics	L2G3IS	±65 / ±130	X, Y	0.10%		9.5kHz	Digital
InvenSense	ITG-31N1	±250, ±500, ±1000, ±2000	X, Y, Z		10,000 gm	400kHz	Digital
InvenSense	ITG-3200	±2000	X, Y, Z		10,000 gm	400kHz	Digital
InvenSense	IDG500	±500/110	X, Y	<1%	10,000 gm	1-1000Hz	Analogue
Maxim Integrated	MAX21000+	±31.25, ±62.5, ±125, ±250	X, Y, Z	0.20%	10,000 gm	400Hz	Digital
Murata Electronics, North America	SCR1100-D02	±100	X	±0.5%	3000 gm	50Hz	Digital/SPI
Murata Electronics, North America	SCC1300-D02 (also has accelerations sensing capability)	±100	X	±0.5%	3000 gm	50Hz	Digital/SPI
Bosch Sensortec	BMG160	±125 ~ ±2000	X, Y, Z	±0.05%	2000 gm, 10,000 gm	2kHz	I ² C, SPI
EPSON	XV-3500CB	±100		±5%			
MTC Industries and Research	MFG-5100	±120	1-axis	±0.2%	2000 gm		Digital
MTC Industries and Research	MRG-5200	±320	1-axis	±0.1%	2000 gm	50Hz	Analogue or digital

Rugged seems to be the keyword

It comes as no surprise though, that the sensor which is used to detect a free-fall should not be the first one to bonk out on impact.

The bias stability for gyros may be pretty numbers in the datasheet, but everything goes out of the window once you get your device out into the real world. Gravity sensitivity and environmental factors like heat, all play a part here. This is why bias stability and vibration rejections are some of the key parameters being looked at. Analog Devices' ADXRS64x family of low-noise, vibration-rejecting yaw rate gyroscopes are drop-in performance upgrades to existing designs using the ADXRS62x family.

For modern applications such as oil-downhole monitoring, UAV inertial measurements and industrial robotics, there is an increased demand for rugged accelerometers. Of course, another area that requires these accelerometers

is the exponentially growing mobile devices segment. With this demand in mind, the last year has seen the launch of tougher accelerometers that can withstand heavy impacts.

A new line of sensors that are insensitive to temperature changes or gradients, with signal output unaffected by electromagnetic interference, and requiring no warm-up time was brought out by Silicon Designs in the last half of 2013. All Silicon Designs' accelerometers feature a custom-integrated circuit with onboard sensing amplifier and differential output stage, with a 0.5V-4.5V single-ended or ±4V differential output, proportional to the amount of measured acceleration.

Laser accelerometers

Researchers at Caltech, the California University of Technology, are working on accelerometers that work with lasers. An accelerometer normally uses an electrical circuit, whilst a laser accelerometer uses laser light instead

of electricity. The optical cavity of this accelerometer is very small (about 20 microns long, only a single micron deep and few tenths of a micron thick). It contains two silicon nanobeams that are situated in an accelerometer as the two sides of a zipper that has a proof mass attached to one of its sides.

The moment a laser light enters the accelerometer, the nanobeams act as a 'light pipe.' These nanobeams guide the light to be bounced back and forth in between its holes. The movement of the proof mass results in the change of the intensity of the laser light that is reflected out. This reflected laser light is so sensitive to the motion of the proof mass that it helps in the determination of even the slightest displacement.

The laser accelerometers are still under research to find the cost-effective ways of using laser with accelerometers. ●

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